

<IGBT Modules>

# **CM100DY-13T**

**HIGH POWER SWITCHING USE INSULATED TYPE** 



Collector current I<sub>c</sub> ..... 100A Collector-emitter voltage V<sub>CES</sub> ..... 650V Maximum junction temperature T<sub>vjmax</sub> ...... **175°**C •dual switch (half-bridge)

**Dimension in mm** 

- Nickel-plating tab terminals
- •RoHS Directive compliant
- •UL Recognized under UL1557, File No. E323585

#### **APPLICATION**

AC Motor Control, Motion/Servo Control, Power supply, etc.

#### **OPTION** (Below options are available.)

•PC-TIM (Phase Change Thermal Interface Material) pre-apply (Note8)

#### **OUTLINE DRAWING & INTERNAL CONNECTION**

94 (SCREWING DEPTH) 80±0.25 23 23 17 17 (5.2) Ð Ð 34 8 15) 22 Ð 3-M5 NUTS 21.3 8.8 2-Ø6.5 MOUNTING HOLES TAB #110 t=0.5 30<sup>+1</sup>.5 8 28. LABEL (53.4) (13.3)0 4 28. ⊚∏ INTERNAL CONNECTION Tolerance otherwise specified Division of Dimension Tolerance -08 ±0.2 Es2) Es2) 0.5 to 3 ±0.3 Di1 3 to 6 over to 30 ±0.5 C1 over 6 E2 to 120 over 30 ±0.8 Di2 over 120 to 400 -О Е 🗒 ±1.2 JIS B 0405 c -02

#### MAXIMUM RATINGS (Tvj=25 °C, unless otherwise specified)

Symbol	Item	Conditions	Rating	Unit	
V <sub>CES</sub>	Collector-emitter voltage	G-E short-circuited	650	V	
V <sub>GES</sub>	Gate-emitter voltage	C-E short-circuited	± 20	V	
lc		DC, T <sub>C</sub> =143 °C* (Note2, 4)	100	•	
I <sub>CRM</sub>	Collector current	Pulse, Repetitive (Note3)	200	A	
P <sub>tot</sub>	Total power dissipation	T <sub>c</sub> =25 °C (Note2, 4)	775	W	
IE (Note1)		DC (Note2)	100	•	
IERM (Note1)	Emitter current	Pulse, Repetitive (Note3)	200	A	
Visol	Isolation voltage	Terminals to base plate, RMS, f=60 Hz, AC 1 min	4000	V	
T <sub>vjmax</sub>	Maximum junction temperature	Instantaneous event (overload) (Note8)	175	- ℃	
T <sub>Cmax</sub>	Maximum case temperature				
$T_{vjop}$	Operating junction temperature	Continuous operation (under switching) (Note8)	-40 ~ +150	- °C	
T <sub>stg</sub>	Storage temperature	-	-40 ~ +150*		

#### ELECTRICAL CHARACTERISTICS (Tvj=25 °C, unless otherwise specified)

Currente e l	lite we	Conditions			Limits		
Symbol	Item	Conditions		Min.	Тур.	Max.	Unit
I <sub>CES</sub>	Collector-emitter cut-off current	V <sub>CE</sub> =V <sub>CES</sub> , G-E short-circuited		-	-	1.0	mA
I <sub>GES</sub>	Gate-emitter leakage current	V <sub>GE</sub> =V <sub>GES</sub> , C-E short-circuited		-	-	0.5	μA
$V_{GE(th)}$	Gate-emitter threshold voltage	I <sub>C</sub> =10 mA, V <sub>CE</sub> =10 V		5.4	6.0	6.6	V
		I <sub>C</sub> =100 A, V <sub>GE</sub> =15 V,	T <sub>vj</sub> =25 °C	-	1.35	1.65	v
V <sub>CEsat</sub>		Refer to the figure of test circuit	T <sub>vj</sub> =125 °C	-	1.45	-	
(Terminal)		(Note5)	T <sub>vj</sub> =150 °C	-	1.50	-	
	Collector-emitter saturation voltage	I <sub>C</sub> =100 A,	T <sub>vj</sub> =25 °C	-	1.30	1.55	
V <sub>CEsat</sub>		V <sub>GE</sub> =15 V,	T <sub>vj</sub> =125 °C	-	1.35	-	V
(Chip)		(Note5)	T <sub>vj</sub> =150 °C	-	1.35	-	
Cies	Input capacitance		-	-	13.4	nF	
C <sub>oes</sub>	Output capacitance	V <sub>CE</sub> =10 V, G-E short-circuited		-	-		0.6
$C_{\text{res}}$	Reverse transfer capacitance		-	-	0.3		
$Q_{G}$	Gate charge	V <sub>CC</sub> =300 V, I <sub>C</sub> =100 A, V <sub>GE</sub> =15 V		-	0.41	-	μC
t <sub>d(on)</sub>	Turn-on delay time	V <sub>cc</sub> =300 V, I <sub>c</sub> =100 A, V <sub>GE</sub> =±15 V, R <sub>G</sub> =6.2 Ω, Inductive load		-	-	200	ns
tr	Rise time			-	-	150	
$t_{d(off)}$	Turn-off delay time			-	-	400	
t <sub>f</sub>	Fall time			-	-	400	
		I <sub>E</sub> =100 A, G-E short-circuited,	T <sub>vj</sub> =25 °C	-	2.05	2.85	1
V <sub>EC</sub> (Note.1)		Refer to the figure of test circuit	T <sub>vj</sub> =125 °C	-	1.95	-	V
(Terminal)		(Note5)	T <sub>vj</sub> =150 °C	-	1.95	-	
	<ul> <li>Emitter-collector voltage</li> </ul>	I <sub>E</sub> =100 A,	T <sub>vj</sub> =25 °C	-	1.90	2.65	
V <sub>EC</sub> (Note.1)		G-E short-circuited,	T <sub>vj</sub> =125 °C	-	1.80	-	V
(Chip)		(Note5)	T <sub>vj</sub> =150 °C	-	1.80	30 -	
t <sub>rr</sub> <sup>(Note1)</sup>	Reverse recovery time	V <sub>CC</sub> =300 V, I <sub>E</sub> =100 A, V <sub>GE</sub> =±15 V,		-	-	150	ns
Q <sub>rr</sub> (Note1)	Reverse recovery charge	$R_{G}$ =6.2 $\Omega$ , Inductive load		-	3.5	-	μC
Eon	Turn-on switching energy per pulse	V <sub>CC</sub> =300 V, I <sub>C</sub> =I <sub>E</sub> =100 A,		-	1.2	-	
E <sub>off</sub>	Turn-off switching energy per pulse	V <sub>GE</sub> =±15 V, R <sub>G</sub> =6.2 Ω, T <sub>vi</sub> =150 °C,		-	5.1	-	mJ
Err (Note1)	Reverse recovery energy per pulse	Inductive load		-	1.8	-	mJ
R <sub>CC'+EE'</sub>	Internal lead resistance	Main terminals-chip, per switch, Tc=25 °C (Note4)		-	0.2	-	mΩ
r <sub>q</sub>	Internal gate resistance	Per switch		-	0	-	Ω

\*: The value of PC-TIM applied module is limited by the heat resistant temperature of PC-TIM.

#### THERMAL RESISTANCE CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
	item	Conditions	Min.	Тур.	Max.	Unit
$R_{th(j-c)Q}$	Thermal resistance	Junction to case, per Inverter IGBT (Note4)	-	-	193	K/kW
$R_{th(j-c)D}$	memarresistance	Junction to case, per Inverter FWD (Note4)	-	-	304	N/KVV
$R_{th(c-s)}$	Contact thermal resistance	Case to heat sink, per 1 module Thermal grease applied (Note4,6,8)	-	36.6	-	K/kW

#### **MECHANICAL CHARACTERISTICS**

Symbol	ltom	Conditions	Conditions		Limits		
	Item	Conditions		Min.	Тур.	Max.	Unit
Mt	Mounting torque	Main terminals	M 5 screw	2.5	3.0	3.5	N∙m
Ms	Mounting torque	Mounting to heat sink	M 6 screw	3.5	4.0	4.5	N∙m
ds	Creepage distance	Terminal to terminal		18.4	-	-	mm
		Terminal to base plate		21.1	-	-	
da	Classes	Terminal to terminal		9.6	-	-	
	Clearance	Terminal to base plate		16.7	-	-	mm
ec	Flatness of base plate	On the centerline (Note7)		±0	-	+200	μm
m	mass	-		-	120	-	g

\*. This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU and (EU) 2015/863.

Note1. Represent ratings and characteristics of the anti-parallel, emitter-collector free-wheeling diode (FWD).

2. Junction temperature  $(T_{vj})$  should not increase beyond  $T_{vjmax}$  rating.

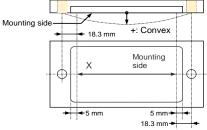
3. Pulse width and repetition rate should be such that the device junction temperature  $(T_{vj})$  dose not exceed  $T_{vjmax}$  rating.

4. Case temperature (T<sub>C</sub>) and heat sink temperature (T<sub>S</sub>) are defined on the each surface (mounting side) of base plate and heat sink just under the chips. Refer to the figure of chip location.

5. Pulse width and repetition rate should be such as to cause negligible temperature rise. Refer to the figure of test circuit.

6. Typical value is measured by using thermally conductive grease of  $\lambda$ =3.0 W/(m·K)/D<sub>(C-S)</sub>=50 µm.

7. The base plate (mounting side) flatness measurement point is as follows of the following figure.



8. Long term performance related to thermal conductive grease and PC-TIM (including but not limited to aspects such as the increase of thermal resistance due to pumping out, etc.) should be verified under your specific application conditions. Each temperature condition (T<sub>vj max</sub>, T<sub>vj op</sub>, T<sub>C max</sub>) must be maintained below the maximum rated temperature throughout consideration of the temperature rise even for long term usage.

### <IGBT Modules> CM100DY-13T HIGH POWER SWITCHING USE INSULATED TYPE

#### **RECOMMENDED OPERATING CONDITIONS**

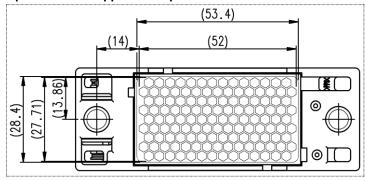
Symbol	Itom	Conditions	Limits			Linit
	Item	Conditions	Min.	Тур.	Max.	Unit
V <sub>cc</sub>	(DC) Supply voltage	Applied across C1-E2 terminals	-	300	450	V
$V_{\text{GEon}}$	Gate (-emitter drive) voltage	Applied across G1-Es1/G2-Es2 terminals	13.5	15.0	16.5	V
R <sub>G</sub>	External gate resistance	Per switch	6.2	-	62	Ω

#### CHIP LOCATION (Top view)

(94) (80)C2E1 E2 C1 (+)÷ **—** 3 18.8(Tr1) = N Ì 18.4(Di1) Tr1D 18.8(Tr2) (34) 2 17.0 18.5(Di2) i in **m** 5 ÷ 比 0 -Œ Ð Τ đ ABEL SIDE ώ 4 'n. 7.0 64 0 29. 42. 57

Tr1/Tr2: IGBT, Di1/Di2: FWD

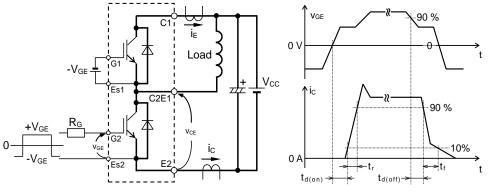
Option: PC-TIM applied baseplate outline

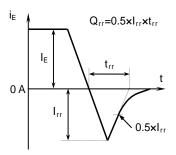


Dimension in mm, tolerance: ±1 mm

### <IGBT Modules> CM100DY-13T HIGH POWER SWITCHING USE INSULATED TYPE

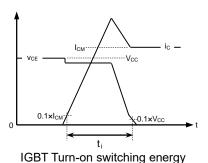
#### TEST CIRCUIT AND WAVEFORMS

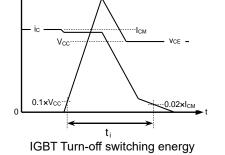


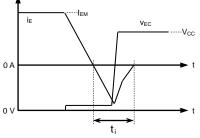


Switching characteristics test circuit and waveforms

trr, Qrr characteristics test waveform



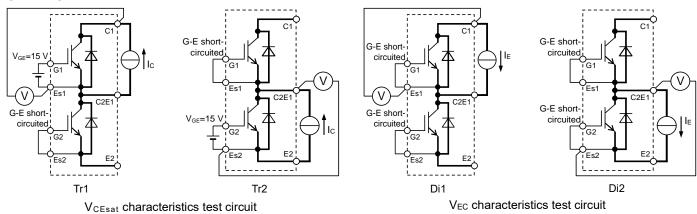




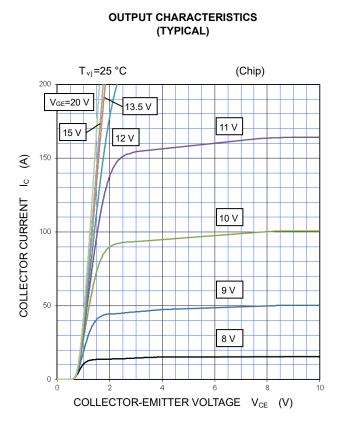
FWD Reverse recovery energy

Turn-on / Turn-off switching energy and Reverse recovery energy test waveforms (Integral time instruction drawing)

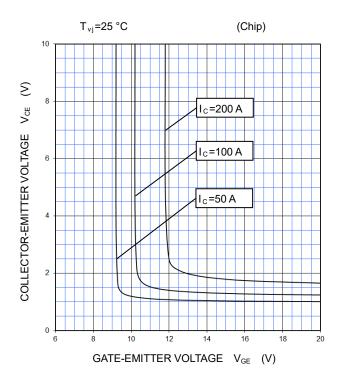
#### **TEST CIRCUIT**

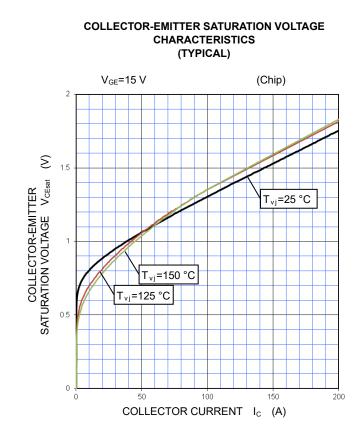


#### PERFORMANCE CURVES

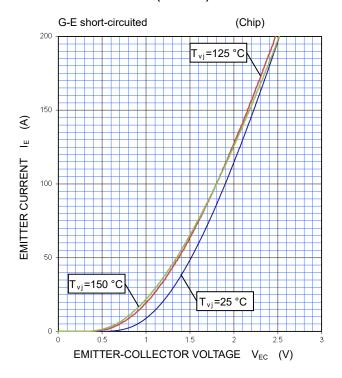


## COLLECTOR-EMITTER VOLTAGE CHARACTERISTICS (TYPICAL)

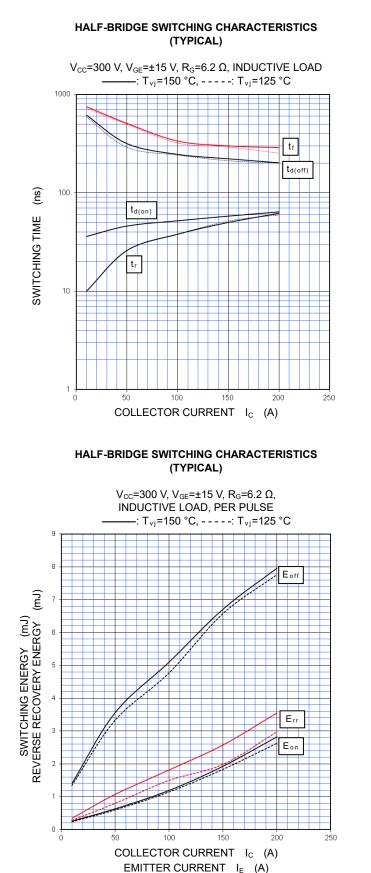


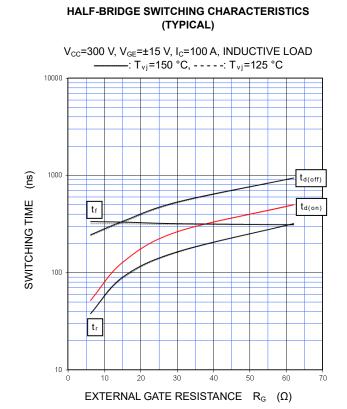


#### FREE WHEELING DIODE FORWARD CHARACTERISTICS (TYPICAL)

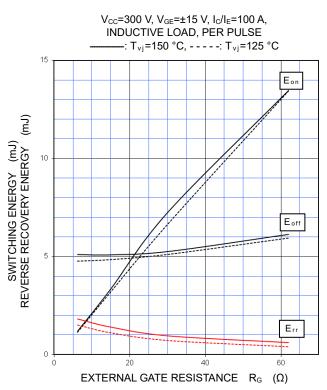


#### PERFORMANCE CURVES



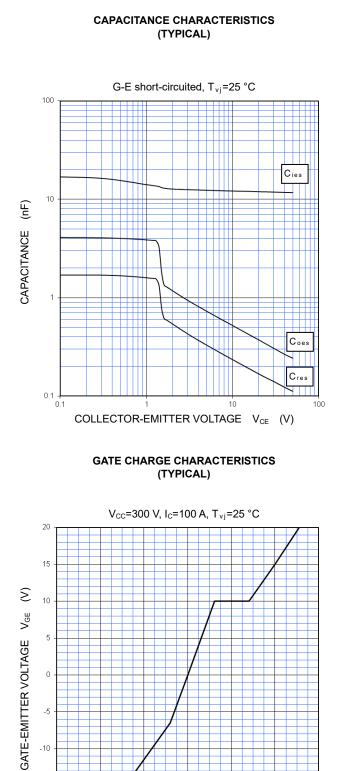


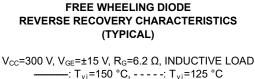
## HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

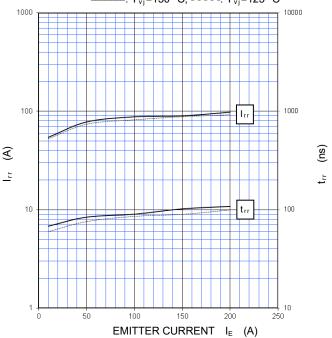


### <IGBT Modules> CM100DY-13T HIGH POWER SWITCHING USE INSULATED TYPE

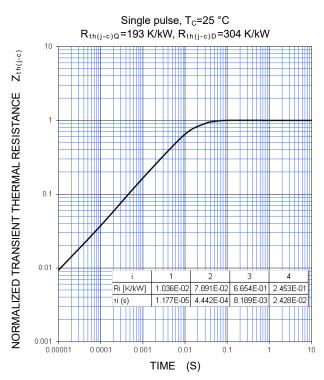
#### PERFORMANCE CURVES







## TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS (MAXIMUM)



-400

-200

Ó

GATE CHARGE Q<sub>G</sub> (nC)

200

400

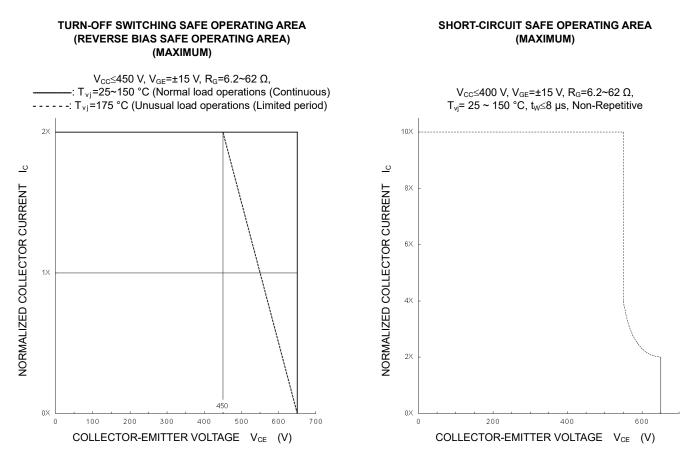
600

-15

-20

-600

#### PERFORMANCE CURVES



Note: The characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

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